

<b>Notice of References Cited</b>	Application/Control No. 10/762,931		Applicant(s)/Patent Under Reexamination HEINER ET AL.	
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#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0035109 A1	02-2003	Hartwich et al.	356/435
*	B	US-6,448,064 B1	09-2002	Vo-Dinh et al.	435/287.2
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	D	US-			
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	K	US-			
	L	US-			
	M	US-			

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#### NON-PATENT DOCUMENTS

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